ALPHA & OMEGA SEMICONDUCTOR

AOM020V120X2

1200 V αSiC Silicon Carbide Power MOSFET

Features

- Proprietary αSiC MOSFET technology
- Low loss, with low $R_{DS(ON)}$
- Fast switching with low R_G and low capacitance
- Optimized gate drive voltage (V_{GS} = 15 V)
- Low reverse recovery diode (Qrr)

Applications

Renewable
- EV Charger
- Solar Inverters

Industrial
- UPS
- SMPS
- Motor Drives

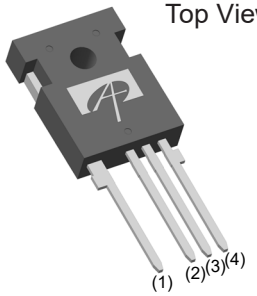
Product Summary

V_{DS} @ $T_{J, max}$	1200 V
I_{DM}	200 A
$R_{DS(ON), typ}$	20 mΩ
Q_{rr}	225 nC
E_{OSS} @ 800 V	88 µJ
100% UIS Tested	

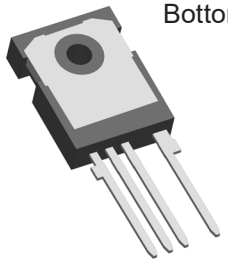
GREEN Product

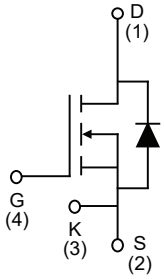
Pin Configuration

Top View



Bottom View





Ordering Part Number	Package Type	Form	Shipping Quantity
AOM020V120X2	TO-247-4L	Tube	30/Tube

Absolute Maximum Ratings

(T_A = 25°C, unless otherwise noted)

Symbol	Parameter		AOM020V120X2	Units
V_{DS}	Drain-Source Voltage		1200	V
$V_{GS, MAX}$	Gate-Source Voltage	Maximum	-8/+18	V
$V_{GS,OP,TRANS}$		Max Transient[A]	-8/+20	
$V_{GS,OP}$		Recommended Operating[B]	-5/+15	
I_D	Continuous Drain Current	T_C = 25°C	89	A
		T_C = 100°C	63	
I_{DM}	Pulsed Drain Current[C]		200	
E_{AS}	Single Pulsed Avalanche Energy[D]		1.0	J
P_D	Power Dissipation[C]	T_C = 25°C	348	W
T_J, T_{STG}	Junction and Storage Temperature Range		-55 to 175	°C
T_L	Maximum lead temperature for soldering purpose, 1/8" from case for 5 seconds		300	°C

Thermal Characteristics

Symbol	Parameter	AOM020V120X2		Units
		Typ	Max	
$R_{\theta JA}$	Maximum Junction-to-Ambient(E,F)		40	°C/W
$R_{\theta JC}$	Maximum Junction-to-Case(G)	0.34	0.43	°C/W

Electrical Characteristics

(T_A = 25°C, unless otherwise noted)

Symbol	Parameter	Conditions		Min	Typ	Max	Units
STATIC							
BV_{DSS}	Drain-Source Breakdown Voltage	I_D=250µA, V_{GS}=0V, T_J=25°C		1200			V
		I_D=250µA, V_{GS}=0V, T_J=175°C		1200			V
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS}=1200V, V_{GS}=0V				100	µA
I_{GSS}	Gate-Body Leakage Current	V_{DS}=0V, V_{GS}=+15/-5V				±200	nA
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS}=V_{GS}, I_D=27mA			2.8		V
$R_{DS(ON)}$	Static Drain-Source On-Resistance	V_{GS}=15V, I_D=27A	T_J=25°C		20	28	mΩ
			T_J=175°C		32		mΩ
g_{FS}	Forward Transconductance	V_{DS}=20V, I_D=27V			23		S
V_{SD}	Diode Forward Voltage	I_S=27A,V_{GS}=-5V			4.3	5	V
DYNAMIC							
C_{iss}	Input Capacitance	V_{GS}=0V, V_{DS}=800V, f=1MHz			5180		pF
C_{oss}	Output Capacitance				208		pF
C_{rss}	Reverse Transfer Capacitance				18		pF
E_{oss}	Coss Stored Energy				88		µJ
R_G	Gate Resistance	f=1MHz			1		Ω
SWITCHING							
Q_g	Total Gate Charge	V_{GS}=-5/+15V, V_{DS}=800V, I_D=30A			166		nC
Q_{gs}	Gate Source Charge				55		nC
Q_{gd}	Gate Drain Charge				39		nC
$t_{D(on)}$	Turn-On Delay Time	V_{GS}=-5V/+15V, V_{DS}=800V, I_D=30A, R_G=2Ω, L_a=30µH, FWD: AOM020V120X2			15		ns
t_r	Turn-On Rise Time				13		ns
$t_{D(off)}$	Turn-Off Delay Time				21		ns
t_f	Turn-Off Fall Time				13		ns
E_{on}	Turn-On Energy				278		µJ
E_{off}	Turn-Off Energy				81		µJ
E_{tot}	Total Switching Energy				359		µJ
t_{rr}	Body Diode Reverse Recovery Time	I_F=30A,dI/dt=1500A/µs, V_{GS}=-5V, V_{DS}=800V			17		ns
I_{rm}	Peak Reverse Recovery Current				24		A
Q_{rr}	Body Diode Reverse Recovery Charge				225		nC

Notes:

A. t_{ON} < 1% *(Duty Cycle)/(Frequency), t < 25hrs over lifetime

B. Device can be operated at V_{GS}=0/15V. Actual operating V_{GS} will depend on application specifics such as parasitic inductance and dV/dt but should not exceed maximum ratings.

C. The power dissipation P_D is based on $T_{J(MAX)}$=175°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

D. L=5mH, I_{AS}=22A, R_G=10Ω, Starting T_J=25°C.

E. The value of $R_{\theta JA}$ is measured with the device in a still air environment with T_A=25°C.

F. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.

G. The value of $R_{\theta JC}$ is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}$=175°C.

H. The static characteristics in Figures 1 to 8 are obtained using < 300µs pulses, duty cycle 0.5% max.

I. These curves are based on $R_{\theta JC}$ which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}$=175°C. The SOA curve provides a single pulse rating.

Typical Electrical and Thermal Characteristics *(Continued)*

T_A = 25 °C, unless otherwise specified.

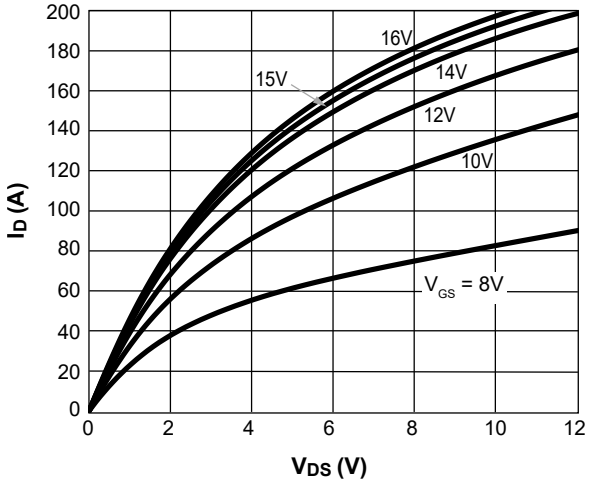


Figure 1. On-Region Characteristics T_J = 25°C

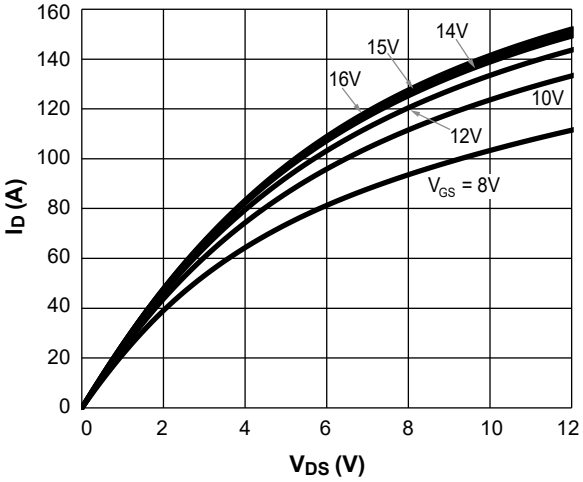


Figure 2. On-Region Characteristics T_J = 175°C

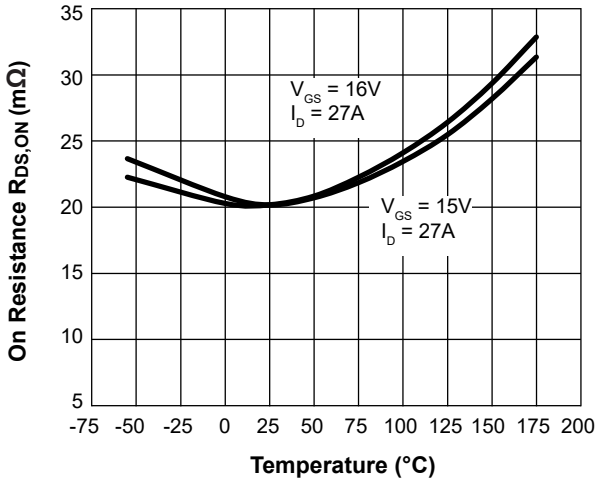


Figure 3. On Resistance vs. Junction Temperature

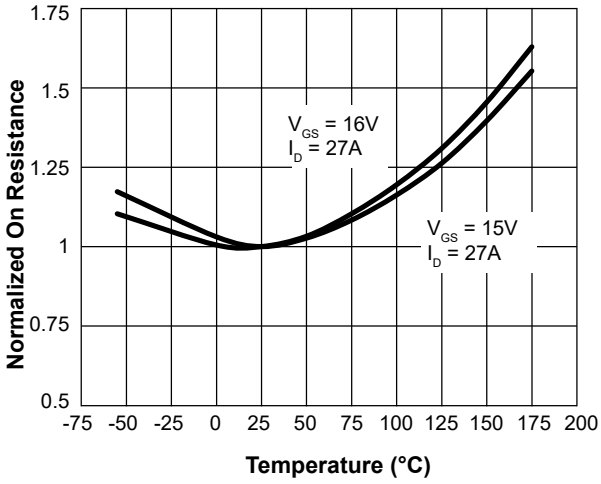


Figure 4. Normalized On Resistance vs. Junction Temperature

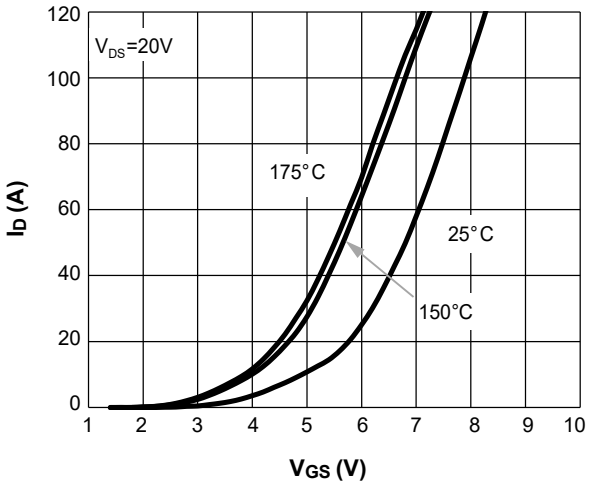


Figure 5. Transfer Characteristics

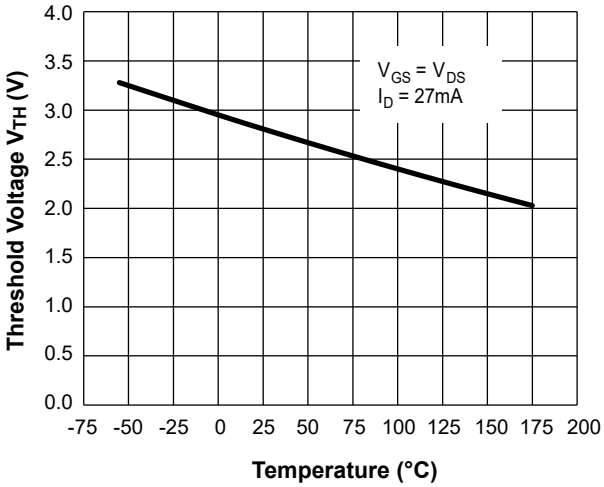


Figure 6. Threshold Voltage vs. Junction Temperature

Typical Electrical and Thermal Characteristics *(Continued)*

T_A = 25 °C, unless otherwise specified.

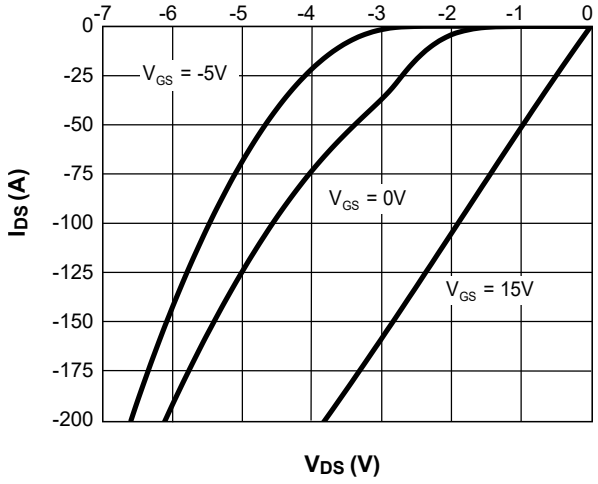


Figure 7. Body-diode Characteristics at 25°C

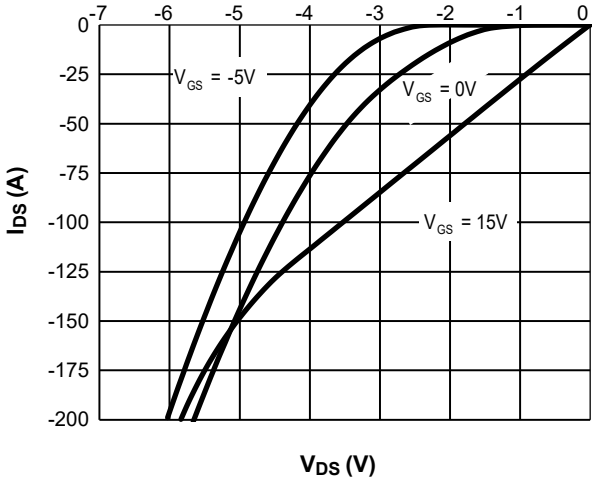


Figure 8. Body-diode Characteristics at 175°C

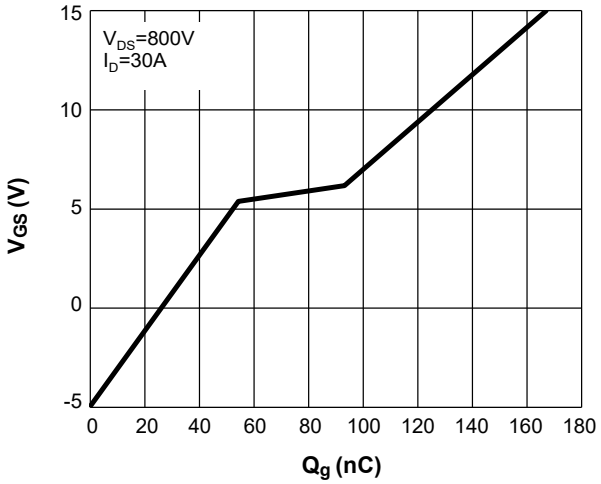


Figure 9. Gate-charge Characteristics

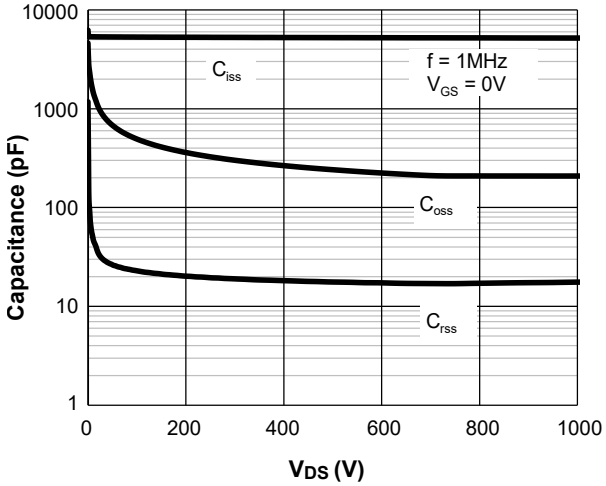


Figure 10. Capacitance Characteristics

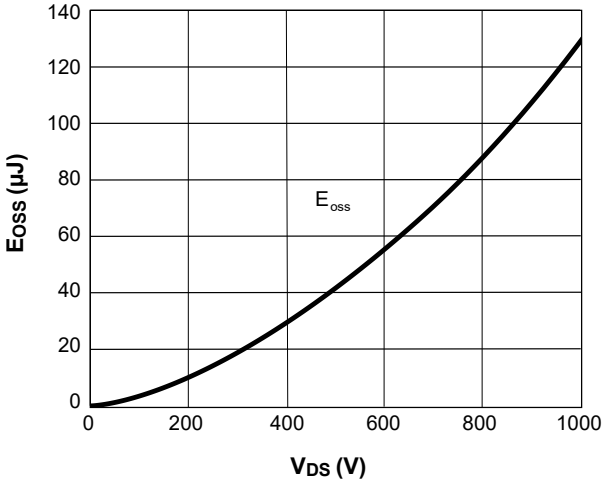


Figure 11. Coss Stored Energy

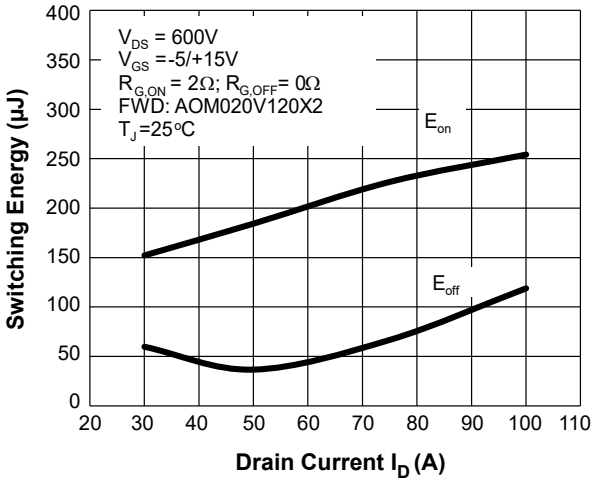


Figure 12. Switching Energy vs. Drain Current

Typical Electrical and Thermal Characteristics *(Continued)*

T_A = 25 °C, unless otherwise specified.

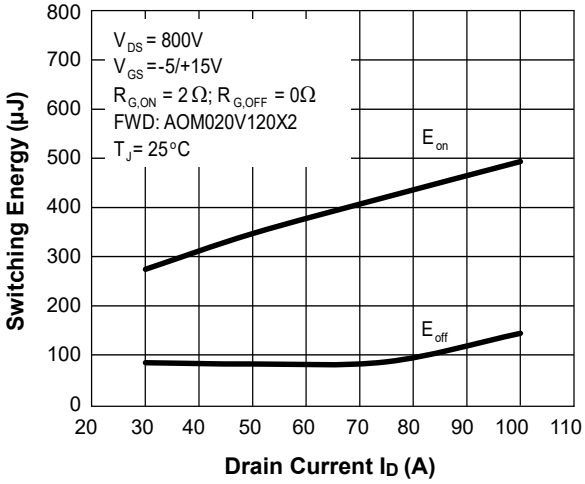


Figure 13. Switching Energy vs. Drain Current

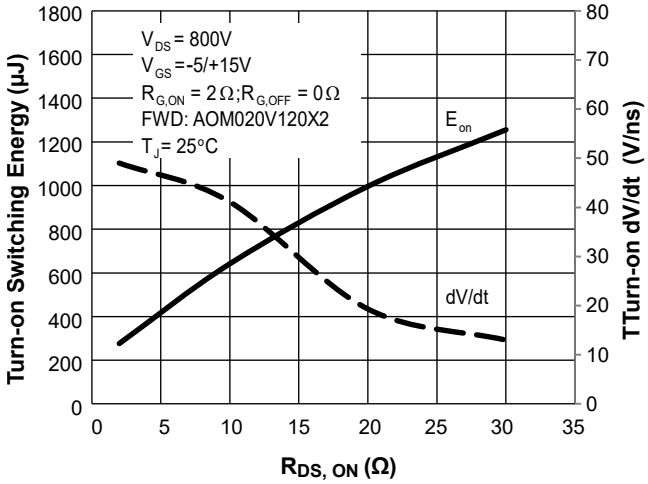


Figure 14. Turn-on Energy and dV/dt vs. External Gate Resistance

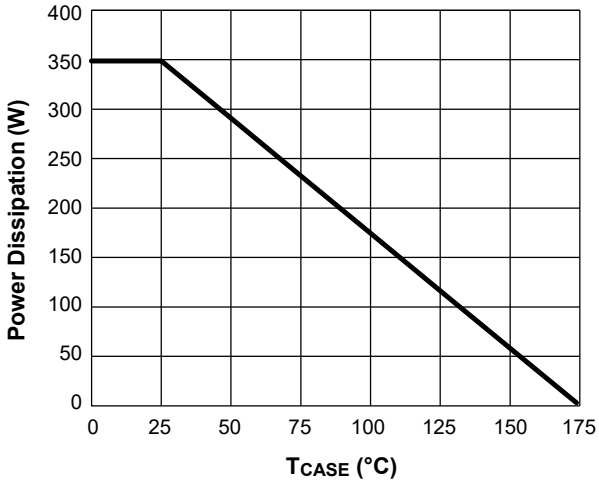


Figure 15. Power De-rating (Note 1)

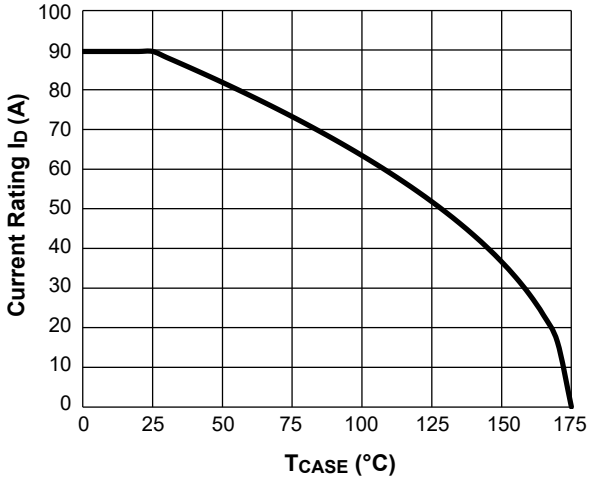


Figure 16. Current De-rating (Note 1)

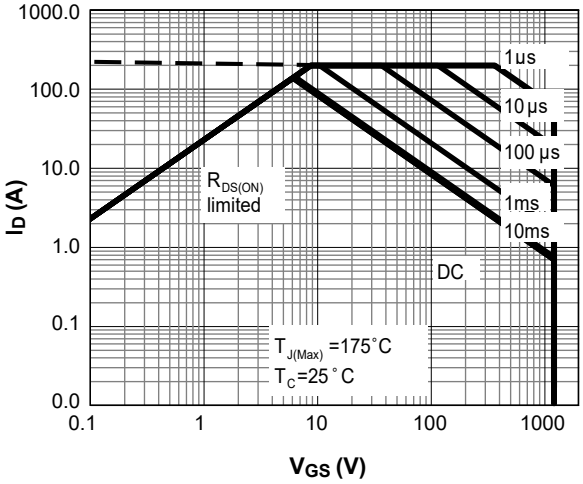


Figure 17. Maximum Forward Biased Safe Operating Area for AOM020V120X2 (Note 1)

Typical Electrical and Thermal Characteristics *(Continued)*

T_A = 25 °C, unless otherwise specified.

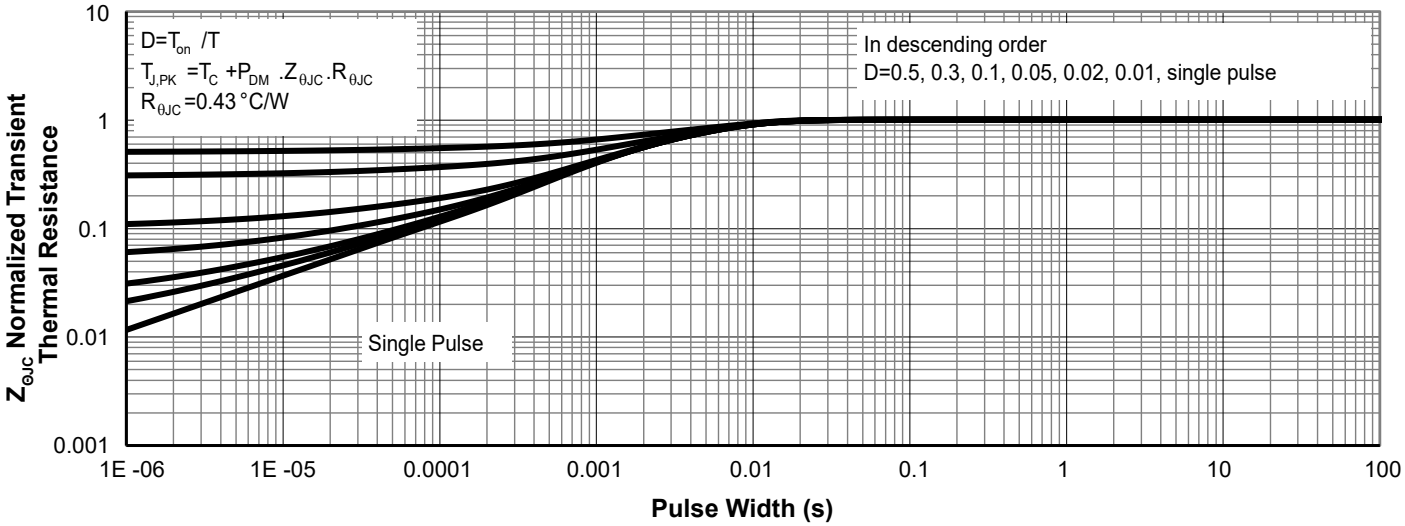


Figure 18. Normalized Maximum Transient Thermal Impedance for AOM020V120X2 (Note I)

Test Circuits and Waveforms

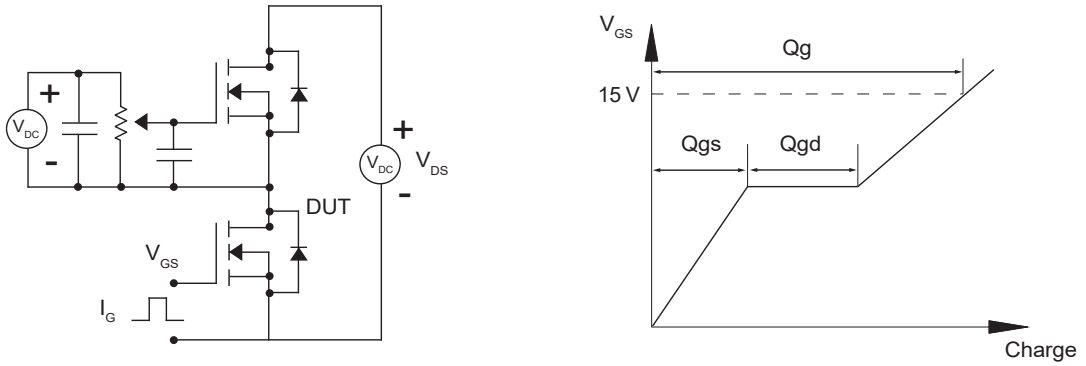


Figure 19. Gate Charge Test Circuits and Waveforms

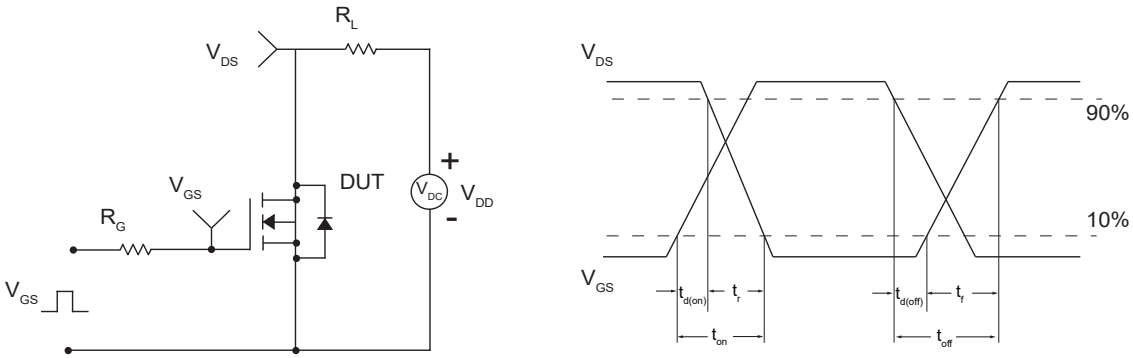


Figure 20. Resistive Switching Test Circuit and Waveforms

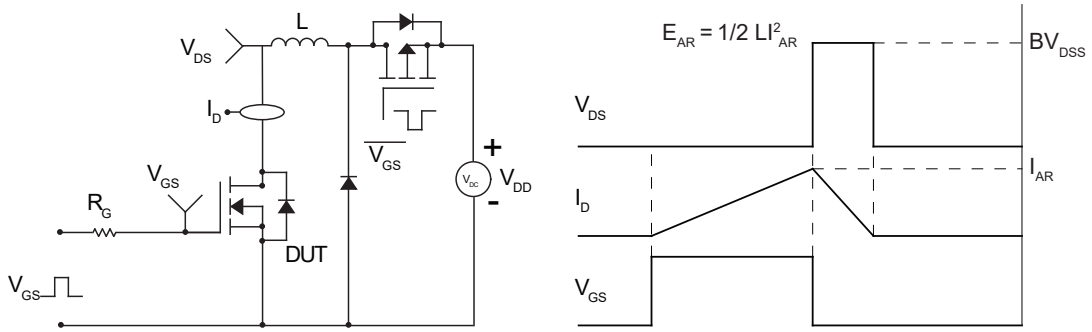


Figure 21. Unclamped Inductive Switching (UIS) Test Circuit and Waveforms

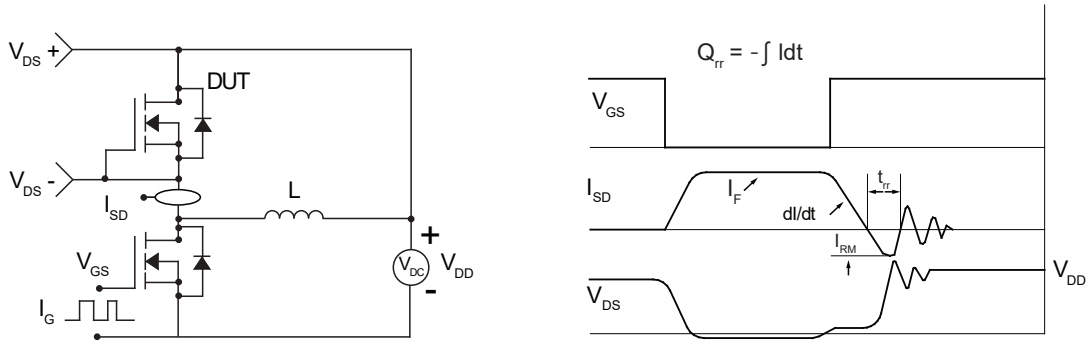
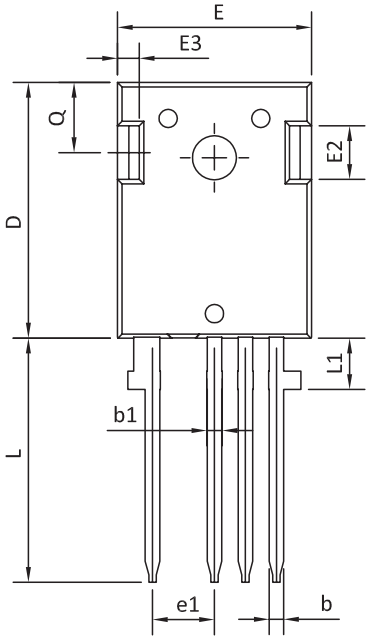
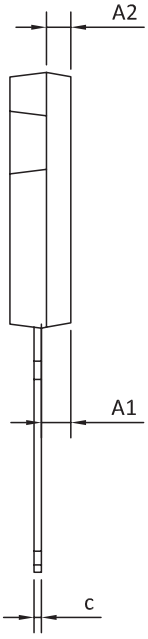


Figure 22. Diode Recovery Test Circuits and Waveforms

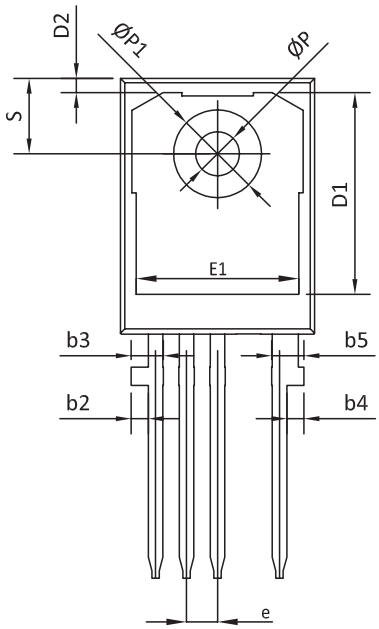
Package Dimensions, TO-247-4L



TOP VIEW

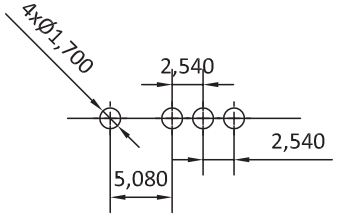


SIDE VIEW



BOTTOM VIEW

SIDE VIEW



RECOMMENDED THROUGH HOLES FOR LAND PATTERN

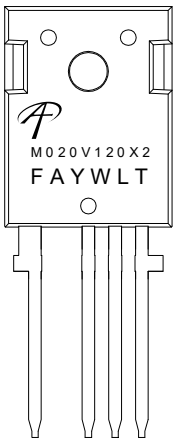
SYMBOLS	DIM. IN MM			DIM. IN INCH		
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.
A	4.90	5.00	5.10	0.193	0.197	0.201
A1	2.32	2.42	2.52	0.091	0.095	0.099
A2	1.90	2.00	2.10	0.075	0.079	0.083
b	1.17	1.22	1.27	0.046	0.048	0.050
b1	1.20	1.30	1.40	0.047	0.051	0.055
b2	1.31	1.41	1.51	0.052	0.056	0.059
b3	2.45	2.65	2.85	0.096	0.104	0.112
b4	1.31	1.41	1.51	0.052	0.056	0.059
b5	2.45	2.65	2.85	0.096	0.104	0.112
c	0.57	0.62	0.67	0.022	0.024	0.026
D	20.80	20.95	21.10	0.819	0.825	0.831
D1	16.25	16.55	16.85	0.640	0.652	0.663
D2	1.00	1.15	1.30	0.039	0.045	0.051
E	15.77	15.92	16.07	0.621	0.627	0.632
E1	13.18	13.33	13.48	0.529	0.525	0.531
E2	4.29	4.39	4.49	0.169	0.173	0.177
E3	1.70	1.80	1.90	0.067	0.071	0.075
e	2.54BSC			0.1000BSC		
e1	5.08BSC			0.2000BSC		
N	4			4		
L	19.82	20.02	20.22	0.780	0.788	0.796
L1	4.01	4.21	4.41	0.158	0.166	0.174
P	3.50	3.60	3.70	0.138	0.142	0.146
P1	7.00	7.20	7.40	0.276	0.283	0.291
Q	5.65	5.75	5.85	0.222	0.226	0.230
S	6.07	6.17	6.27	0.239	0.243	0.247

NOTE:

1. CONTROLLED DIMENSIONS ARE IN MILLIMETERS.

Part Marking

AOM020V120X2
TO-247-4L



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2. A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.